

Notice of References Cited	Application/Control No. 10/003,109	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Thang V. Tran	Art Unit 2653	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0172122	11-2002	Choi et al.	369/59.25
*	B	US-6,813,230	11-2004	Ko et al.	369/275.3
*	C	US-6,587,417	07-2003	Okamoto et al.	369/59.22
*	D	US-6,320,831	11-2001	Inoue et al.	369/47.22
*	E	US-6,282,163	08-2001	Fujiwara, Tsuneo	369/59.2
*	F	US-6,233,219	05-2001	Hori et al.	369/275.4
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.